## USB2000+Spectrometer User-configured for Maximum Flexibility



The USB2000+ Spectrometer is a clever combination of technologies: a powerful 2-MHz analog-to-digital (A/D) converter, programmable electronics, a 2048-element CCD-array detector and a high-speed USB 2.0 port.

This innovative design produces our fastest spectrometer and provides resolution to 0.35 nm (FWHM). The USB2000+ allows users to capture and store a full spectrum into memory every millisecond (that's 1,000 full spectra every second) when the spectrometer is interfaced to a computer via a USB 2.0 port. The USB2000+ is perfect for chemical, biochemical and other applications where fast reactions need to be monitored.

## **Features**

- 1,000 full spectra/second
- Programmable microcontroller
- Modular design hundreds of configurations possible
- Built-to-suit wavelength range and resolution -
- Automatically reads the wavelength calibration coefficients of the spectrometer and configures operating software
- USB-to-PC interface; no external power requirements
- RoHS and CE compliance

## **Programmable Microcontroller**

The USB2000+ has an onboard programmable microcontroller that provides flexibility in controlling the spectrometer and accessories. Through a 22-pin connector, you can implement all operating parameters in the software, such as controlling external light sources, creating processes and routines and retrieving data from external devices. The USB2000+ gives you access to 10 user-programmable digital I/Os for interfacing to other equipment and a pulse generator for triggering other devices.

Physical	
Dimensions:	89.1 mm x 63.3 mm x 34.4 mm
Weight:	190 g
Detector	
Detector:	Sony ILX511B linear silicon CCD array
Detector range:	200-1100 nm
Pixels:	2048 pixels
Pixel size:	14 µm x 200 µm
Pixel well depth:	~62,500 electrons
Sensitivity:	75 photons/count at 400 nm; 41 photons/count at 600 nm
Optical Bench	
Design:	f/4, Symmetrical crossed Czerny-Turner
Focal length:	42 mm input; 68 mm output
Entrance aperture:	5, 10, 25, 50, 100 or 200 µm wide slits or fiber (no slit)
Grating options:	14 different gratings, UV through Shortwave NIR
XR grating option:	Yes
Detector collection lens option:	Yes, L2
OFLV filter options:	OFLV-200-850; OFLV-350-1000
Other bench filter options:	Longpass OF-1 filters
Collimating and focus- ing mirrors:	Standard or SAG+
UV enhanced window:	Yes, UV2 quartz window
Fiber optic connector:	SMA 905 to 0.22 numerical aperture single-strand optical fiber
Spectroscopic	
Wavelength range:	Grating dependent
	~0.3-10.0 nm FWHM
Optical resolution:	
Optical resolution: Signal-to-noise ratio:	250:1 (at full signal)
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Signal-to-noise ratio: A/D resolution:	250:1 (at full signal) 16 bit
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Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range:	250:1 (at full signal) 16 bit 50 RMS counts 2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time:	250:1 (at full signal) 16 bit 50 RMS counts 2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition 1 ms to 65 seconds (20 seconds typical)
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light:	250:1 (at full signal)   16 bit   50 RMS counts   2 x 10 <sup>s</sup> (system); 1300:1 for a single acquisition   1 ms to 65 seconds (20 seconds typical)   <0.05% at 600 nm; <0.10% at 435 nm
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light: Corrected linearity:	250:1 (at full signal)   16 bit   50 RMS counts   2 x 10 <sup>s</sup> (system); 1300:1 for a single acquisition   1 ms to 65 seconds (20 seconds typical)   <0.05% at 600 nm; <0.10% at 435 nm
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light: Corrected linearity: Electronics	250:1 (at full signal)   16 bit   50 RMS counts   2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition   1 ms to 65 seconds (20 seconds typical)   <0.05% at 600 nm; <0.10% at 435 nm
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light: Corrected linearity: Electronics Power consumption:	250:1 (at full signal) 16 bit 50 RMS counts 2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition 1 ms to 65 seconds (20 seconds typical) <0.05% at 600 nm; <0.10% at 435 nm >99.8% 250 mA @ 5 VDC Full scans to memory every 1 ms with USB 2.0 or 1.1 port
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light: Corrected linearity: Electronics Power consumption: Data transfer speed:	250:1 (at full signal) 16 bit 50 RMS counts 2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition 1 ms to 65 seconds (20 seconds typical) <0.05% at 600 nm; <0.10% at 435 nm >99.8% 250 mA @ 5 VDC Full scans to memory every 1 ms with USB 2.0 or 1.1 port 300 ms with serial port
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light: Corrected linearity: Electronics Power consumption: Data transfer speed: Inputs/Outputs:	250:1 (at full signal) 16 bit 50 RMS counts 2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition 1 ms to 65 seconds (20 seconds typical) <0.05% at 600 nm; <0.10% at 435 nm >99.8% 250 mA @ 5 VDC Full scans to memory every 1 ms with USB 2.0 or 1.1 port 300 ms with serial port Yes, onboard digital user-progammable GPIOs
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light: Corrected linearity: Electronics Power consumption: Data transfer speed: Inputs/Outputs: Analog channels:	250:1 (at full signal) 16 bit 50 RMS counts 2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition 1 ms to 65 seconds (20 seconds typical) <0.05% at 600 nm; <0.10% at 435 nm >99.8% 250 mA @ 5 VDC Full scans to memory every 1 ms with USB 2.0 or 1.1 port 300 ms with serial port Yes, onboard digital user-progammable GPIOs No
Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light: Corrected linearity: Electronics Power consumption: Data transfer speed: Inputs/Outputs: Analog channels: Auto nulling: Breakout box compat-	250:1 (at full signal) 16 bit 50 RMS counts 2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition 1 ms to 65 seconds (20 seconds typical) <0.05% at 600 nm; <0.10% at 435 nm >99.8% 250 mA @ 5 VDC Full scans to memory every 1 ms with USB 2.0 or 1.1 port 300 ms with serial port Yes, onboard digital user-progammable GPIOs No No
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Signal-to-noise ratio: A/D resolution: Dark noise: Dynamic range: Integration time: Stray light: Corrected linearity: Electronics Power consumption: Data transfer speed: Inputs/Outputs: Analog channels: Auto nulling: Breakout box compat- ibility: Trigger modes:	250:1 (at full signal) 16 bit 50 RMS counts 2 x 10 <sup>8</sup> (system); 1300:1 for a single acquisition 1 ms to 65 seconds (20 seconds typical) <0.05% at 600 nm; <0.10% at 435 nm >99.8% 250 mA @ 5 VDC Full scans to memory every 1 ms with USB 2.0 or 1.1 port 300 ms with serial port Yes, onboard digital user-progammable GPIOs No No No No